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# Electronic properties of phases in the quasi-binary Bi<sub>2</sub>Se<sub>3</sub>-Bi<sub>2</sub>S<sub>3</sub> system

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We explored the properties of the quasi-binary Bi<sub>2</sub>Se<sub>3</sub>-Bi<sub>2</sub>S<sub>3</sub> system over a wide compositional range. X-ray diffraction analysis demonstrates that rhombohedral crystals can be synthesized within the solid solution interval 0–22 mol% Bi<sub>2</sub>S<sub>3</sub>, while at 33 mol% Bi<sub>2</sub>S<sub>3</sub> only orthorhombic crystals are obtained. Core level photoemission spectroscopy reveals the presence of Bi<sup>3+</sup>, Se<sup>2-</sup> and S<sup>2-</sup> species and the absence of metallic species, thus indicating that S incorporation into Bi<sub>2</sub>Se<sub>3</sub> proceeds prevalently through the substitution of Se with S. Spin- and angle-resolved photoemission spectroscopy shows that topological surface states develop on the surfaces of the Bi<sub>2</sub>Se<sub>3-y</sub>S<sub>y</sub> ( $y \le 0.66$ ) rhombohedral crystals, in close analogy with the prototypical case of Bi<sub>2</sub>Se<sub>3</sub>, while the orthorhombic crystals with higher S content turn out to be trivial semiconductors. Our results connect unambiguously the phase diagram and electronic properties of the Bi<sub>2</sub>Se<sub>3</sub>-Bi<sub>2</sub>S<sub>3</sub> system.

#### Introduction

Topological insulators (TIs) are a new class of materials possessing a bulk band gap, like ordinary band insulators, and protected conducting states on their edges, such as their surfaces. These states, known as Topological Surface States (TSSs), appear because of a combination of spin–orbit coupling and time reversal symmetry.<sup>1</sup> TSSs of TIs display a linear energy–momentum  $E(k_{\parallel})$ relation, which is characteristic of Dirac electrons, and spinmomentum locking, resulting in spin-polarized transport on the surface/edge and significant suppression of backscattering by impurities and defects. These properties make TIs attractive for a variety of nano electronic applications such as spin-transfer torque non-volatile memories<sup>2</sup> and field-effect transistors,<sup>3</sup> but also in the field of optoelectronics for helicity-dependent photocurrents<sup>4,5</sup> and catalysis.<sup>6</sup>

Bi<sub>2</sub>Se<sub>3</sub> and Bi<sub>2</sub>Te<sub>3</sub> belong to a class of compounds called tetradymites and are considered as the three-dimensional prototypical TI materials. Ternary variants such as Bi<sub>2</sub>Te<sub>2</sub>Se, Bi<sub>2</sub>Se<sub>2</sub>Te and Bi2Te2S have also been investigated due to their superior bulk insulating properties with respect to their binary counterparts.<sup>7-10</sup> In this context calculations have predicted Bi<sub>2</sub>Se<sub>2</sub>S to be a stable TI in its stoichiometric form,<sup>11,12</sup> but the few available experimental results are not yet conclusive with respect to this issue. From the material's point of view, it is known that Bi<sub>2</sub>S<sub>3</sub> has an orthorhombic crystalline structure with trivial insulating properties, while Bi<sub>2</sub>Se<sub>3</sub> has a rhombohedral crystalline structure. The Bi<sub>2</sub>Se<sub>3</sub>-Bi<sub>2</sub>S<sub>3</sub> phase diagram shows that these two compounds form two solid solutions over a large composition range. At room temperature the orthorhombic solid solution extends from 0 to  $\sim 67 \text{ mol}\%$ Bi<sub>2</sub>Se<sub>3</sub> and the rhombohedral from 0 to 16 mol% Bi<sub>2</sub>S<sub>3</sub>. A twophase range exists between the solid solutions. An eutectic composition was found at 23 mol% Bi2S3 with the eutectic temperature at around 680 °C<sup>13,14</sup> (Fig. 1(b)).

Recently, transport measurements on  $\text{Bi}_2\text{Se}_{3-y}\text{S}_y$  with  $0 \le y \le 0.21$  indicated the existence of a TSS accompanied by unusual negative magnetoresistance behaviour.<sup>15</sup> In a study of the  $\text{Sr}_x\text{Bi}_2\text{Se}_{3-y}\text{S}_y$  alloy (x = 0.066 and  $0 \le y \le 0.4$ ), it has been indirectly proved that sulphur destroys TSSs and suppresses superconductivity of  $\text{Sr}_x\text{Bi}_2\text{Se}_3$  as a result of a sulphur occupational disorder.<sup>16</sup>

Angle-resolved photoemission spectroscopy (ARPES) has been used to probe in a direct way the electronic structures of different ternary chalcogenides.<sup>17</sup> The available ARPES results show that  $Bi_2Se_2S$  is not a topological insulator<sup>17</sup> in contrast with the theoretical prediction.<sup>11,12</sup> This result is interpreted as a consequence of the fact that the solid solution  $Bi_2Se_{3-y}S_y$ prefers the rhombohedral structure at higher concentration of heavier Se, and the orthorhombic structure at higher concentration of lighter S.

Overall, a picture that reconciles the theoretical and experimental results on the topological properties of the  $Bi_2Se_3$ - $Bi_2S_3$ 

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Fig. 1 (a) Powder XRD patterns measured on the samples extracted from the ingots with different nominal mol% of  $Bi_2S_3$  as indicated in (b). The measured patterns of pure  $Bi_2Se_3$  and  $Bi_2S_3$  corresponding to PDF #00-033-0214 and PDF #03-065-2431 respectively are reported. (b) Phase diagram of  $Bi_2S_3$ - $Bi_2Se_3$ - $Bi_2Se$ 

quasi-binary compounds is still lacking. We revisited the electronic properties of these systems along the entire compositional tie line with the use of bulk sensitive technique X-ray diffraction (XRD) and surface sensitive techniques low energy electron diffraction (LEED), scanning electron microscopy (SEM) with energy dispersive X-ray spectroscopy (EDX), X-ray photoemission spectroscopy (XPS) and ARPES. Spin-resolved ARPES was also employed to access the spin structure of the compounds. We show that rhombohedral single crystal structures are obtained only within the solid solution interval 0 – 22% mol of  $Bi_2S_3$ . All these systems possess spin polarized TSSs, in close analogy with the parent  $Bi_2Se_3$  TI.

## **Experimental details**

Bismuth and selenium were purchased from Sigma Aldrich. Sulphur was purchased from Acros Organics. Bi and S were 99.999% trace metal basis while Se was  $\geq$  99.5% trace metal basis. High quality single crystals along the Bi<sub>2</sub>Se<sub>3</sub>-Bi<sub>2</sub>S<sub>3</sub> compositional tie line were grown by the Bridgman method. Stoichiometric amounts of high purity elements were sealed in evacuated quartz ampoules and heated up to 750 °C at 21 °C h<sup>-1</sup>. The ampoules were maintained at that temperature for 48 h. Thereupon the temperature was slowly reduced to 250 °C at 5 °C h<sup>-1</sup> and then cooled down to room temperature.



Fig. 2 LEED pattern measured on (a)  $Bi_2Se_3$  and (b)  $Bi_2Se_{2.34}S_{0.66}$  at primary electron energy of 66 eV.

Table 1	Composition	of the	e samples	analyzed	in the	present	study

Nominal composition of the charge (Bi <sub>2</sub> S <sub>3</sub> mol%)	Measured composition from EDX spectra (Bi <sub>2</sub> S <sub>3</sub> mol%)	Calculated y from EDX spectra
5	$3.8\pm0.4$	$0.11\pm0.01$
10	$10.8\pm0.9$	$0.32\pm0.03$
15	$14.3 \pm 0.4$	$0.43\pm0.01$
25	$22\pm 1$	$0.66\pm0.03$
33	$36.7 \pm 1.3$	$1.10\pm0.04$

Seven different charges were prepared: pure  $Bi_2Se_3$ , 5 mol%  $Bi_2S_3$ , 10 mol%  $Bi_2S_3$ , 15 mol%  $Bi_2S_3$ , 25 mol%  $Bi_2S_3$ , 28 mol%  $Bi_2S_3$ , 33 mol%  $Bi_2S_3$  and pure  $Bi_2S_3$ .

The XRD patterns of the powdered samples were collected with Rigaku Miniflex600 apparatus. The chemical composition was determined by fitting the EDX spectra measured with Oxford XMax-80 apparatus (with Aztech acquisition and analysis software) installed on a Jeol JSM-7100F field-emission SEM. Table 1 reports the nominal composition of the charges, composition estimated from the EDX analysis and corresponding *y* value in the chemical formula  $Bi_2Se_{3-y}S_y$  of the samples studied by means of photoemission spectroscopy (see Fig. 3–6).

The photoemission experiments were carried out at Elettra synchrotron, Trieste, Italy on clean surfaces obtained by cleaving the samples in situ in ultra-high vacuum with pressure lower than  $1.2 \times 10^{-10}$  mbar. LEED was used to monitor the crystalline structure and quality of the surface. The XPS experiments were carried out at a VUV-Photoemission beamline using a Scienta R4000 hemispherical electron energy analyzer. All the XPS spectra were measured at room temperature using photon energy of 650 eV with a total energy resolution of  $\sim 200$  meV. S 2p and Se 3s core level spectra were fitted using Voigt functions. The ARPES measurements were carried out at the APE-LE beamline using a VG Scienta DA30 hemispherical electron energy analyzer. The spin-resolved ARPES measurements were performed with the Very Low Energy Electron Diffraction B (VLEED-B) polarimeter in the in-plane magnetization configuration (spin parallel to the sample surface in the direction perpendicular to the analyzer slit, *i.e.* perpendicular to the angular dispersion direction).<sup>18</sup> The measurements were carried out in a  $30^{\circ}$  angular mode. The electron energy analyzer is mounted 45° with respect to the photon beam direction and the spectra collected near normal emission. ARPES and spin-resolved ARPES measurements were carried out with an overall energy resolution of 40 meV and 100 meV energy resolution respectively.

#### Results and discussion

The crystalline structure of the samples was analyzed by powder XRD (Fig. 1(a)).



**Fig. 3** Bi 4f, Se 3d, Se 3s and S 2s core level spectra measured on the samples extracted from the charges with the composition indicated in the figures. Fitting curves are reported in the case of Se 3s and S 2s core levels. In the energy region of Bi 4f, the peaks corresponding to S 2p and Se 3p core levels are also visible with very low intensity.

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Fig. 4 Electronic band structure measured near  $E_F$  by means of ARPES on different  $Bi_2Se_{3-y}S_y$  samples. Maps (a–e) were measured with  $h\nu = 50$  eV, and map (f) with  $h\nu = 45$  eV.  $k_{\parallel} = 0$  Å<sup>-1</sup> represents the  $\Gamma$  point. Dashed lines in panel (a,b,d and e) delimit stripes of the photoemission map of width  $\Delta k_{\parallel} = 0.048$  Å<sup>-1</sup> and centered at  $k_n = -0.03$  Å<sup>-1</sup> and  $k_p = +0.06$  Å<sup>-1</sup>. EDC<sub> $m\uparrow\downarrow$ </sub> were collected within these stripes (in order to increase the signal to noise ratio) and used to extract the SEDCs reported in Fig. 6(a)–(h) (see text).

The samples corresponding to the pure Bi<sub>2</sub>Se<sub>3</sub> composition and the nominal compositions with 5, 10 and 15 mol% of Bi<sub>2</sub>S<sub>3</sub> were found to crystallize in the rhombohedral structure (Fig. 1(a)). EDX analysis of the single crystals extracted from the ingots showed that they possess a homogeneous chemical composition corresponding to the nominal composition of the charges. The XRD patterns of the samples with 25 and 28 mol% of Bi<sub>2</sub>S<sub>3</sub> showed diffraction peaks corresponding to both the orthorhombic and rhombohedral structure. The coexistence of the two different phases is in accordance with the Bi<sub>2</sub>S<sub>3</sub>-Bi<sub>2</sub>Se<sub>3</sub> phase diagram (Fig. 1(b))<sup>14</sup> where the two-phase (orthorhombic and rhombohedral) range at room temperature extends from ~16 to 33 mol% of  $Bi_2S_3$ . Interestingly, we could extract a 400  $\times$  400  $\mu$ m<sup>2</sup> rhombohedral single crystal from the sample with nominal 25 mol% Bi<sub>2</sub>S<sub>3</sub>. Also, in this case the EDX analysis showed a homogeneous composition, with 22  $\pm$  1 mol% of  $Bi_2S_3$  and an S content exceeding the room-temperature solid solubility limit. This apparent anomaly can be explained with the phase diagram by Liu *et al.*<sup>14</sup> and the crystal growth conditions. We grew our crystals by cooling from the liquidus field. During cooling of the 25%  $Bi_2S_3$  sample the rhombohedral phase with the eutectic composition crystallized first. Because the line separating the rhombohedral phase field from the two-phase field is temperature-dependent and shifts to higher  $Bi_2S_3$  content with increasing the temperature, the crystallized rhombohedral phase contains more sulphur. Obviously, such state is frozen during further cooling to room temperature and results in the supersaturated  $Bi_2S_3$ - $Bi_2Se_3$ solid solution. This allows us to investigate the rhombohedral solid solution in the extended range up to 22 mol%  $Bi_2S_3$ .

The chemical and electronic properties of the  $Bi_2Se_{3-y}S_y$ alloys were analyzed with XPS and ARPES using synchrotron



**Fig. 5** Electronic band structure of  $Bi_2Se_{2.68}S_{0.32}$  near  $E_F$  measured with (a)  $h\nu = 30$  eV and (b)  $h\nu = 45$  eV.  $k_{\parallel} = 0$  Å<sup>-1</sup> represents the  $\Gamma$  point. The chosen photon energies do not change the dispersion of the TSS, but strongly modulate the intensity of the surface and bulk features.

radiation. The spot sizes used for the XPS and ARPES analyses are of  $\sim 200 \times 50 \ \mu\text{m}^2$  and  $\sim 150 \times 50 \ \mu\text{m}^2$ , respectively. Chemically homogeneous crystals, with areas larger than the spot sizes have been characterized ex situ by SEM-EDX before and after the photoemission experiments. From here on, samples are indicated by their chemical composition obtained by the EDX analysis (see Table 1) according to formula  $Bi_2Se_{3-\nu}S_{\nu}$ . During the photoemission experiments, the crystalline structure of the sample surfaces was checked by means of LEED. For S content in the  $0 < y \le 0.66$  range we observed sharp spots forming a hexagonal diffraction pattern like that of Bi2Se3 (Fig. 2). This is indicative that our preparation gives rise to large and crystallographically ordered domains exposing the (0001) plane of the rhombohedral phase. According to the threefold symmetry of the Bi<sub>2</sub>Se<sub>3</sub> (0001) surface (plane group p3m1) two sets of reflections with different intensity are expected in the LEED pattern,19 in contrast to our experimental pattern. A possible explanation for this behavior is that the electron energy of 66 eV minimizes the intensity contrast between the non-equivalent first order reflections. Alternatively, the presence of stacking faults in the crystal can produce  $180^{\circ}$  rotated domains,<sup>20</sup> and then result in a hexagonal pattern. The latest scenario is more frequent in epitaxially grown films than in bulk crystals. The LEED pattern of the orthorhombic phase (not shown) has rectangular symmetry.

An insight into the chemical properties of the surface of different solid solutions was obtained by XPS (Fig. 5). The binding energy (BE) of Bi  $4f_{7/2}$  (158.0 eV), Se  $3d_{5/2}$  (53.3 eV), Se 3s (228.5 eV), and S 2s (225.0 eV) does not change as a function of S content and corresponds to that of Bi, Se and S atoms in Bi<sub>2</sub>Se<sub>3</sub><sup>21</sup> and Bi<sub>2</sub>S<sub>3</sub>.<sup>22</sup> This is an indication that S prevalently substitutes Se in Bi<sub>2</sub>Se<sub>3</sub>, and does not form clusters or an inhomogeneous distribution as proposed in ref. 15 to explain the anomalous transport properties of the Bi<sub>2</sub>Se<sub>3-y</sub>S<sub>y</sub> alloys.

Fig. 4 reports the electronic band structure measured near the Fermi level ( $E_{\rm F}$ ). All Bi<sub>2</sub>Se<sub>3-y</sub>S<sub>y</sub> compounds with 0  $\leq$  $y \leq$  0.66 possess two linearly dispersive bands crossing at  $\Gamma$ at 0.31  $\pm$  0.045 eV BE. They have a surface character, as their dispersion does not change as a function of the photon energy (see Fig. 5).<sup>23,24</sup> We identify these features as TSSs and their crossing as the Dirac point (DP). A DP below  $E_{\rm F}$  is an indication of electron doping caused by defects.<sup>24</sup> The variation of the DPs within  $\pm$  45 meV can be due to slightly different concentration of intrinsic defects in the samples. These changes do not depend in a monotonic way on the S content and so are not assigned to S-driven doping effects. TSSs disappear at the composition Bi<sub>2</sub>Se<sub>2</sub>S, which is purely orthorhombic (magenta spectrum in Fig. 1(a)) and expected to exhibit the electronic properties of a trivial insulator.

The systematic ARPES measurements clearly show that TSSs are not destroyed by diluting  $Bi_2Se_3$  with  $Bi_2S_3$  as long as the rhombohedral crystal symmetry is maintained. In the  $Bi_2Se_{3-y}S_y$  this is possible up to y = 0.66. For higher S content, it is impossible to obtain a thermodynamically stable rhombohedral structure.

Fig. 6 reports the spin analysis of the electronic structure of the  $Bi_2Se_{3-\nu}S_{\nu}$  samples. The spin-resolved measurements are carried out with the VLEED-B polarimeter in the in-plane magnetization configuration. In this configuration, the measured Energy Distribution Curves for the two opposite directions of the target magnetization  $m (EDC_{m \uparrow \downarrow})$  are used to calculate the in-plane spin polarization P using the formula  $P = \frac{1 \text{EDC}_{m\uparrow} - \text{EDC}_{m\downarrow}}{\text{SEDC}_{m\uparrow} + \text{EDC}_{m\downarrow}}, \text{ where } S = 0.3 \text{ is the effective Sherman}$ function.<sup>18</sup> The EDC<sub> $m\uparrow\downarrow$ </sub> were collected in the two  $\Delta k_{\parallel}$  intervals centered at  $k_p$  and  $k_n$  and of width 0.048 Å<sup>-1</sup>, which are indicated by dashed lines in Fig. 4. We point out that  $k_p$  and  $k_n$  are non-symmetric with respect to  $\Gamma$ . The spin-resolved electron distribution curves (SEDCs) extracted from the measured  $\text{EDC}_{m\uparrow\downarrow}$  using the formula  $\frac{(1 \pm P)(\text{EDC}_{m\uparrow} + \text{EDC}_{m\downarrow})}{2}$  are reported in Fig. 6(a-h). The corresponding spin polarizations P are reported in Fig. 6(i-l).

In all SEDCs there are two features: one between ~0.3 eV BE and  $E_{\rm F}$ , and another one between ~0.3 and ~0.7 eV BE. The first feature is entirely ascribed to the upper branch of the TSS and displays the expected reversal of P at the opposite sides of  $\Gamma$ . The behaviour of the second feature is less clear due to the overlap of the lower branch of the TSS with the bulk valence



**Fig. 6** (a–d) Spin-resolved electron distribution curves extracted from the  $EDC_{m\uparrow\downarrow}$  measured at  $k_p$  and (e–h) at  $k_n$  on different Bi<sub>2</sub>Se<sub>3-y</sub>S<sub>y</sub> samples. The corresponding in-plane spin polarizations *P* at  $k_p$  (green) and *P* at  $k_n$  (magenta) are shown in (i–l). All the spectra were measured at photon energy 50 eV at *T* = 78 K.

states, which tends to reduce *P*, and the asymmetric acquisition geometry. For pure Bi<sub>2</sub>Se<sub>3</sub>, *P* is much lower at  $k_n$  than at  $k_p$  (Fig. 6(i)). This is even more clear for the S containing samples (Fig. 6(j–l)), where *P* approaches zero for  $k_n$  but is finite for  $k_p$ . However, these spurious effects do not hide the overall similar spin structure for the Bi<sub>2</sub>Se<sub>3-y</sub>S<sub>y</sub> samples with  $0 \le y \le 0.66$ .

In summary, high quality single crystals of Bi<sub>2</sub>Se<sub>3-y</sub>S<sub>y</sub> could be prepared with the Bridgman method. The ARPES and spinresolved ARPES measurements unambiguously show that the Bi<sub>2</sub>Se<sub>3-y</sub>S<sub>y</sub> solid solution supports a spin-polarized TSS for S content in the range  $0 \le y \le 0.66$ . For these compositions, it is possible to isolate rhombohedral single crystals having homogeneous structural and chemical properties over an area of hundreds of  $\mu$ m.<sup>2</sup> The core level spectra show that upon S incorporation, Bi is 3+, Se and S are 2– and no metallic species are formed. This is an indication that S most likely substitutes Se in Bi<sub>2</sub>Se<sub>3</sub> and does not form clusters or an inhomogeneous distribution as proposed by ref. 15. With S incorporation the DP of Bi<sub>2</sub>Se<sub>3</sub> does not shift systematically. As soon as the structure changes from rhombohedral to orthorhombic, the material becomes a trivial insulator.

## Conflicts of interest

There are no conflicts to declare.

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